



Welcome to [E-XFL.COM](https://www.e-xfl.com)

Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Active
Number of LABs/CLBs	18144
Number of Logic Elements/Cells	-
Total RAM Bits	165888
Number of I/O	317
Number of Gates	1000000
Voltage - Supply	1.425V ~ 1.575V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 85°C (TA)
Package / Case	484-BGA
Supplier Device Package	484-FPBGA (23x23)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/ax1000-1fgg484i

Table of Contents

General Description

Device Architecture	1-1
Design Environment	1-7
Summary	1-8
Related Documents	1-8

Detailed Specifications

Operating Conditions	2-1
Thermal Characteristics	2-6
I/O Specifications	2-9
Voltage-Referenced I/O Standards	2-43
Differential Standards	2-50
Module Specifications	2-54
Routing Specifications	2-61
Global Resources	2-66
Accelerator Clock Management System	2-75
Embedded Memory	2-86
Other Architectural Features	2-106
Programming	2-110

Package Pin Assignments

BG729	3-1
FG256	3-9
FG324	3-16
FG484	3-21
FG676	3-37
FG896	3-52
FG1152	3-71
PQ208	3-84
CQ208	3-89
CQ256	3-94
CQ352	3-98
CG624	3-115

Datasheet Information

List of Changes	4-1
Datasheet Categories	4-7
Safety Critical, Life Support, and High-Reliability Applications Policy	4-7

1 – General Description

Axcelerator devices offer high performance at densities of up to two million equivalent system gates. Based upon the Microsemi AX architecture, Axcelerator has several system-level features such as embedded SRAM (with complete FIFO control logic), PLLs, segmentable clocks, chip-wide highway routing, and carry logic.

Device Architecture

AX architecture, derived from the highly-successful SX-A sea-of-modules architecture, has been designed for high performance and total logic module utilization (Figure 1-1). Unlike in traditional FPGAs, the entire floor of the Axcelerator device is covered with a grid of logic modules, with virtually no chip area lost to interconnect elements or routing.

Programmable Interconnect Element

The Axcelerator family uses a patented metal-to-metal antifuse programmable interconnect element that resides between the upper two layers of metal (Figure 1-2 on page 1-2). This completely eliminates the channels of routing and interconnect resources between logic modules (as implemented on traditional FPGAs) and enables the efficient sea-of-modules architecture. The antifuses are normally open circuit and, when programmed, form a permanent, passive, low-impedance connection, leading to the fastest signal propagation in the industry. In addition, the extremely small size of these interconnect elements gives the Axcelerator family abundant routing resources.

The very nature of Microsemi's nonvolatile antifuse technology provides excellent protection against design pirating and cloning (FuseLock technology). Typical cloning attempts are impossible (even if the security fuse is left unprogrammed) as no bitstream or programming file is ever downloaded or stored in the device. Reverse engineering is virtually impossible due to the difficulty of trying to distinguish between programmed and unprogrammed antifuses and also due to the programming methodology of antifuse devices (see "Security" on page 2-108).

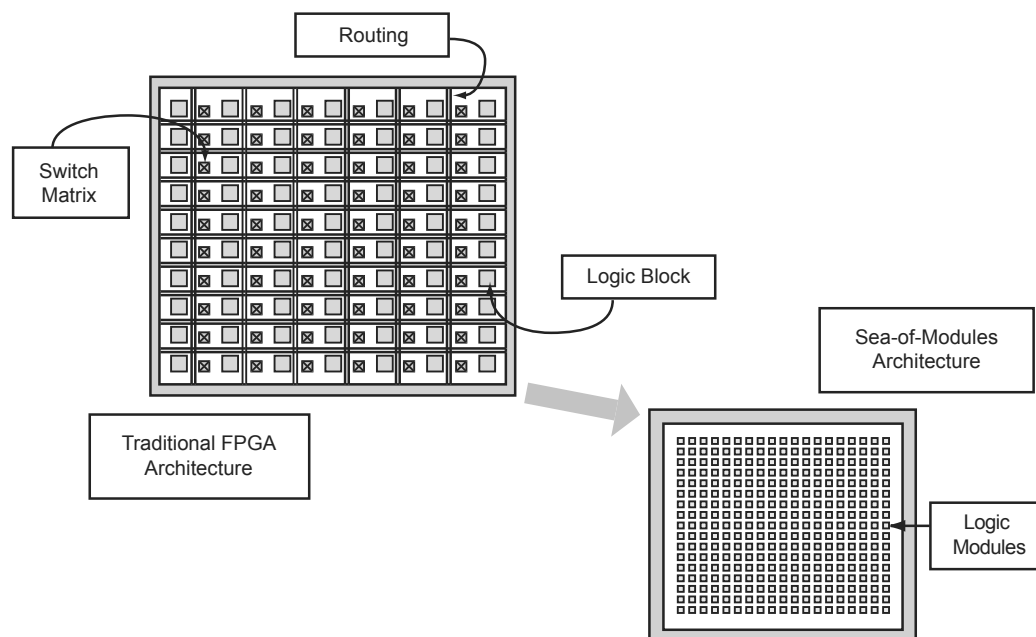


Figure 1-1 • Sea-of-Modules Comparison

Thermal Characteristics

Introduction

The temperature variable in Microsemi's Designer software refers to the junction temperature, not the ambient temperature. This is an important distinction because dynamic and static power consumption cause the chip junction temperature to be higher than the ambient temperature. EQ 1 can be used to calculate junction temperature.

$$T_J = \text{Junction Temperature} = \Delta T + T_a$$

EQ 1

Where:

T_a = Ambient Temperature

ΔT = Temperature gradient between junction (silicon) and ambient

$$\Delta T = \theta_{ja} * P$$

EQ 2

Where:

P = Power

θ_{ja} = Junction to ambient of package. θ_{ja} numbers are located under Table 2-6 on page 2-7.

Package Thermal Characteristics

The device junction-to-case thermal characteristic is θ_{jc} , and the junction-to-ambient air characteristic is θ_{ja} . The thermal characteristics for θ_{ja} are shown with two different air flow rates. θ_{jc} values are provided for reference. The absolute maximum junction temperature is 125°C.

The maximum power dissipation allowed for commercial- and industrial-grade devices is a function of θ_{ja} . A sample calculation of the absolute maximum power dissipation allowed for an 896-pin FBGA package at commercial temperature and still air is as follows:

$$\text{Maximum Power Allowed} = \frac{\text{Max. junction temp. (°C)} - \text{Max. ambient temp. (°C)}}{\theta_{ja}(\text{°C/W})} = \frac{125^\circ\text{C} - 70^\circ\text{C}}{13.6^\circ\text{C/W}} = 4.04 \text{ W}$$

Table 2-8 • I/O Standards Supported by the Axcelerator Family

I/O Standard	Input/Output Supply Voltage (VCCI)	Input Reference Voltage (VREF)	Board Termination Voltage (VTT)
LVTTL	3.3	N/A	N/A
LVC MOS 2.5 V	2.5	N/A	N/A
LVC MOS 1.8 V	1.8	N/A	N/A
LVC MOS 1.5 V (JDEC8-11)	1.5	N/A	N/A
3.3V PCI/PCI-X	3.3	N/A	N/A
GTL+ 3.3 V	3.3	1.0	1.2
GTL+ 2.5 V*	2.5	1.0	1.2
HSTL Class 1	1.5	0.75	0.75
SSTL3 Class 1 and II	3.3	1.5	1.5
SSTL2 Class1 and II	2.5	1.25	1.25
LVDS	2.5	N/A	N/A
LVPECL	3.3	N/A	N/A

Note: *2.5 V GTL+ is not supported across the full military temperature range.

Table 2-9 • Supply Voltages

VCCA	VCCI	Input Tolerance	Output Drive Level
1.5 V	1.5 V	3.3 V	1.5 V
1.5 V	1.8 V	3.3 V	1.8 V
1.5 V	2.5 V	3.3 V	2.5 V
1.5 V	3.3 V	3.3 V	3.3 V

Table 2-10 • I/O Features Comparison

I/O Assignment	Clamp Diode	Hot Insertion	5 V Tolerance	Input Buffer	Output Buffer
LVTTL	No	Yes	Yes ¹	Enabled/Disabled	
3.3 V PCI, 3.3 V PCI-X	Yes	No	Yes ^{1, 2}	Enabled/Disabled	
LVC MOS 2.5 V	No	Yes	No	Enabled/Disabled	
LVC MOS 1.8 V	No	Yes	No	Enabled/Disabled	
LVC MOS 1.5 V (JESD8-11)	No	Yes	No	Enabled/Disabled	
Voltage-Referenced Input Buffer	No	Yes	No	Enabled/Disabled	
Differential, LVDS/LVPECL, Input	No	Yes	No	Enabled	Disabled ³
Differential, LVDS/LVPECL, Output	No	Yes	No	Disabled	Enabled ⁴

Notes:

1. Can be implemented with an IDT bus switch.
2. Can be implemented with an external resistor.
3. The OE input of the output buffer must be deasserted permanently (handled by software).
4. The OE input of the output buffer must be asserted permanently (handled by software).

I/O Module Timing Characteristics

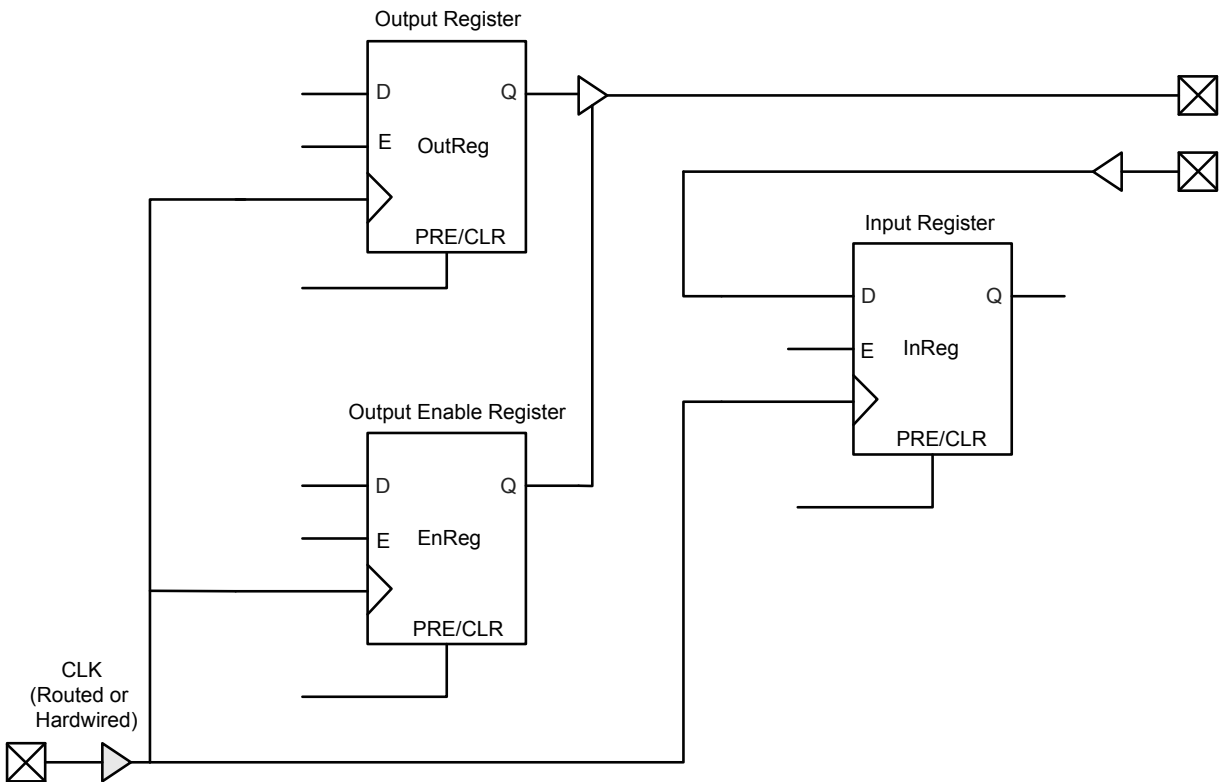


Figure 2-11 • Timing Model

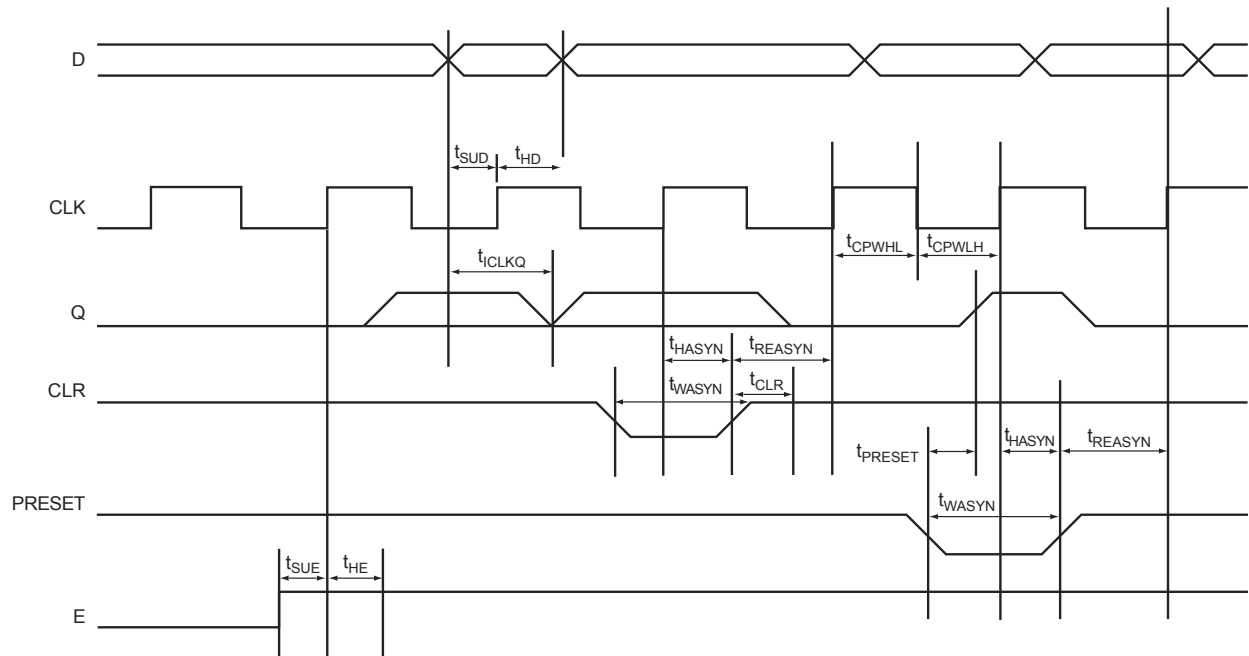


Figure 2-12 • Input Register Timing Characteristics

Table 2-22 • 3.3 V LVTTTL I/O Module

Worst-Case Commercial Conditions VCCA = 1.425 V, VCCI = 3.0 V, T_J = 70°C (continued)

		–2 Speed		–1 Speed		Std Speed		
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	Units
LVTTTL Output Drive Strength = 1 (8 mA) / High Slew Rate								
t _{DP}	Input Buffer		1.68		1.92		2.26	ns
t _{PY}	Output Buffer		4.23		4.81		5.66	ns
t _{ENZL}	Enable to Pad Delay through the Output Buffer—Z to Low		4.64		5.28		6.21	ns
t _{ENZH}	Enable to Pad Delay through the Output Buffer—Z to High		4.23		4.81		5.66	ns
t _{ENLZ}	Enable to Pad Delay through the Output Buffer—Low to Z		1.89		1.91		1.91	ns
t _{ENHZ}	Enable to Pad Delay through the Output Buffer—High to Z		2.01		2.02		2.03	ns
t _{IOCLKQ}	Sequential Clock-to-Q for the I/O Input Register		0.67		0.77		0.90	ns
t _{IOCLKY}	Clock-to-output Y for the I/O Output Register and the I/O Enable Register		0.67		0.77		0.90	ns
t _{SUD}	Data Input Set-Up		0.23		0.27		0.31	ns
t _{SUE}	Enable Input Set-Up		0.26		0.30		0.35	ns
t _{HD}	Data Input Hold		0.00		0.00		0.00	ns
t _{HE}	Enable Input Hold		0.00		0.00		0.00	ns
t _{CPWHL}	Clock Pulse Width High to Low	0.39		0.39		0.39		ns
t _{CPWLH}	Clock Pulse Width Low to High	0.39		0.39		0.39		ns
t _{WASYN}	Asynchronous Pulse Width	0.37		0.37		0.37		ns
t _{REASYN}	Asynchronous Recovery Time		0.13		0.15		0.17	ns
t _{HASYN}	Asynchronous Removal Time		0.00		0.00		0.00	ns
t _{CLR}	Asynchronous Clear-to-Q		0.23		0.27		0.31	ns
t _{PRESET}	Asynchronous Preset-to-Q		0.23		0.27		0.31	ns

Differential Standards

Physical Implementation

Implementing differential I/O standards requires the configuration of a pair of external I/O pads, resulting in a single internal signal. To facilitate construction of the differential pair, a single I/O Cluster contains the resources for a pair of I/Os. Configuration of the I/O Cluster as a differential pair is handled by Designer software when the user instantiates a differential I/O macro in the design.

Differential I/Os can also be used in conjunction with the embedded Input Register (InReg), Output Register (OutReg), Enable Register (EnReg), and Double Data Rate (DDR). However, there is no support for bidirectional I/Os or tristates with these standards.

LVDS

Low-Voltage Differential Signal (ANSI/TIA/EIA-644) is a high-speed, differential I/O standard. It requires that one data bit is carried through two signal lines, so two pins are needed. It also requires an external resistor termination. The voltage swing between these two signal lines is approximately 350 mV.

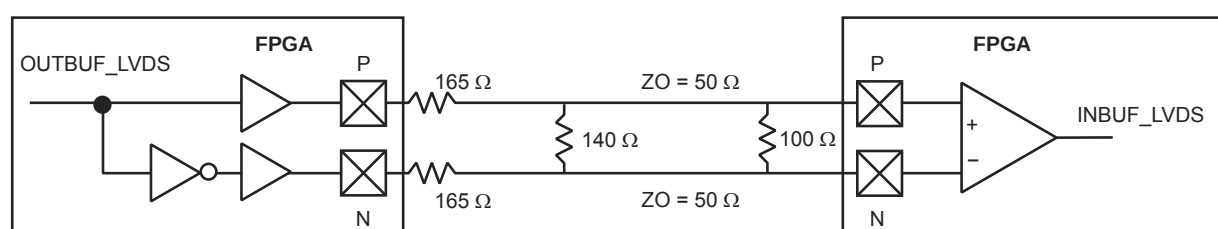


Figure 2-25 • LVDS Board-Level Implementation

The LVDS circuit consists of a differential driver connected to a terminated receiver through a constant-impedance transmission line. The receiver is a wide-common-mode-range differential amplifier. The common-mode range is from 0.2 V to 2.2 V for a differential input with 400 mV swing.

To implement the driver for the LVDS circuit, drivers from two adjacent I/O cells are used to generate the differential signals (note that the driver is not a current-mode driver). This driver provides a nominal constant current of 3.5 mA. When this current flows through a 100 Ω termination resistor on the receiver side, a voltage swing of 350 mV is developed across the resistor. The direction of the current flow is controlled by the data fed to the driver.

An external-resistor network (three resistors) is needed to reduce the voltage swing to about 350 mV. Therefore, four external resistors are required, three for the driver and one for the receiver.

Table 2-56 • DC Input and Output Levels

DC Parameter	Description	Min.	Typ.	Max.	Units
VCCI ¹	Supply Voltage	2.375	2.5	2.625	V
VOH	Output High Voltage	1.25	1.425	1.6	V
VOL	Output Low Voltage	0.9	1.075	1.25	V
VODIFF	Differential Output Voltage	250	350	450	mV
VOCM	Output Common Mode Voltage	1.125	1.25	1.375	V
VICM2	Input Common Mode Voltage	0.2	1.25	2.2	V

Notes:

1. $\pm 5\%$
2. Differential input voltage = ± 350 mV.

R-Cell

Introduction

The R-cell, the sequential logic resource of the Axcelerator devices, is the second logic module type in the AX family architecture. It includes clock inputs for all eight global resources of the Axcelerator architecture as well as global presets and clears (Figure 2-31).

The main features of the R-cell include the following:

- Direct connection to the adjacent logic module through the hardwired connection DCIN. DCIN is driven by the DCOUT of an adjacent C-cell via the Direct-Connect routing resource, providing a connection with less than 0.1 ns of routing delay.
- The R-cell can be used as a standalone flip-flop. It can be driven by any C-cell or I/O modules through the regular routing structure (using DIN as a routable data input). This gives the option of using the R-Cell as a 2:1 MUXed flip-flop as well.
- Provision of data enable-input (S0).
- Independent active-low asynchronous clear (CLR).
- Independent active-low asynchronous preset (PSET). If both CLR and PSET are low, CLR has higher priority.
- Clock can be driven by any of the following (CKP selects clock polarity):
 - One of the four high performance hardwired fast clocks (HCLKs)
 - One of the four routed clocks (CLKs)
 - User signals
- Global power-on clear (GCLR) and preset (GPSET), which drive each flip-flop on a chip-wide basis.
 - When the Global Set Fuse option in the Designer software is unchecked (by default), GCLR = 0 and GPSET = 1 at device power-up. When the option is checked, GCLR = 1 and GPSET = 0. Both pins are pulled High when the device is in user mode. Refer to the "Simulation Support for GCLR/GPSET in Axcelerator" section of the *Antifuse Macro Library Guide* for information on simulation support for GCLR and GPSET.
- S0, S1, PSET, and CLR can be driven by routed clocks CLKE/F/G/H or user signals.
- DIN and S1 can be driven by user signals.

As with the C-cell, the configuration of the R-cell to perform various functions is handled automatically for the user through Microsemi's extensive macro library (see the *Antifuse Macro Library Guide* for a complete listing of available AX macros).

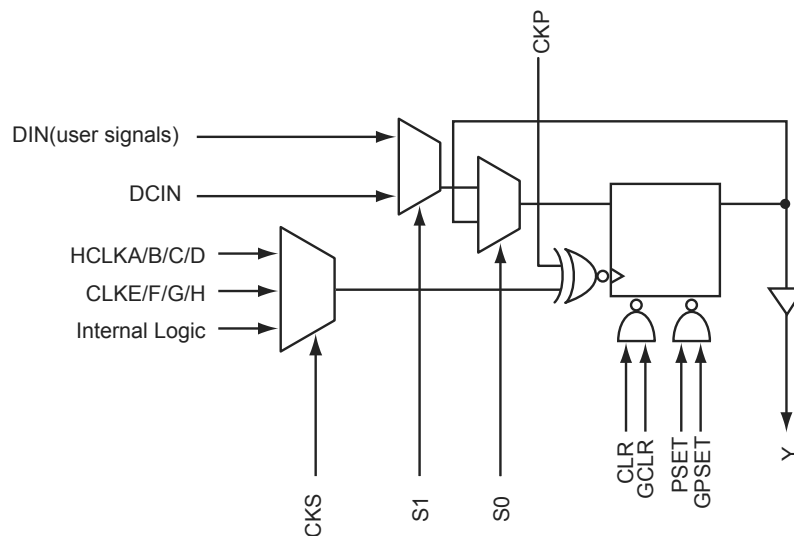


Figure 2-31 • R-Cell

Table 2-89 • One RAM Block

Worst-Case Commercial Conditions VCCA = 1.425 V, VCCI = 3.0 V, T_J = 70°C

		–2 Speed		–1 Speed		Std Speed		Units
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	
Write Mode								
t _{WDASU}	Write Data Setup vs. WCLK		1.08		1.23		1.45	ns
t _{WDAHD}	Write Data Hold vs. WCLK		0.22		0.25		0.30	ns
t _{WADSU}	Write Address Setup vs. WCLK		1.08		1.23		1.45	ns
t _{WADHD}	Write Address Hold vs. WCLK		0.00		0.00		0.00	ns
t _{WENSU}	Write Enable Setup vs. WCLK		1.08		1.23		1.45	ns
t _{WENHD}	Write Enable Hold vs. WCLK		0.22		0.25		0.30	ns
t _{WCKH}	WCLK Minimum High Pulse Width	0.75		0.75		0.75		ns
t _{WCLK}	WCLK Minimum Low Pulse Width	0.88		0.88		0.88		ns
t _{WCKP}	WCLK Minimum Period	1.63		1.63		1.63		ns
Read Mode								
t _{RADSU}	Read Address Setup vs. RCLK		0.81		0.92		1.08	ns
t _{RADHD}	Read Address Hold vs. RCLK		0.00		0.00		0.00	ns
t _{RENSU}	Read Enable Setup vs. RCLK		0.81		0.92		1.08	ns
t _{RENHD}	Read Enable Hold vs. RCLK		0.00		0.00		0.00	ns
t _{RCK2RD1}	RCLK-to-OUT (Pipelined)		1.32		1.51		1.77	ns
t _{RCK2RD2}	RCLK-to-OUT (Non-Pipelined)		2.16		2.46		2.90	ns
t _{RCLKH}	RCLK Minimum High Pulse Width	0.77		0.77		0.77		ns
t _{RCLKL}	RCLK Minimum Low Pulse Width	0.93		0.93		0.93		ns
t _{RCKP}	RCLK Minimum Period	1.70		1.70		1.70		ns

Note: Timing data for this single block RAM has a depth of 4,096. For all other combinations, use Microsemi's timing software.

Timing Characteristics

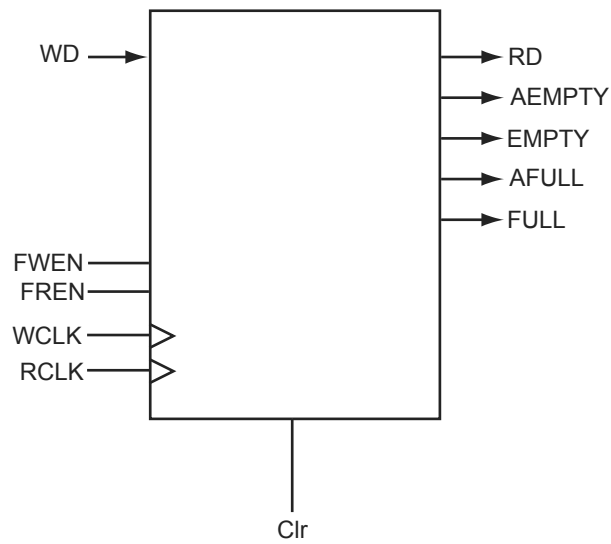


Figure 2-66 • FIFO Model

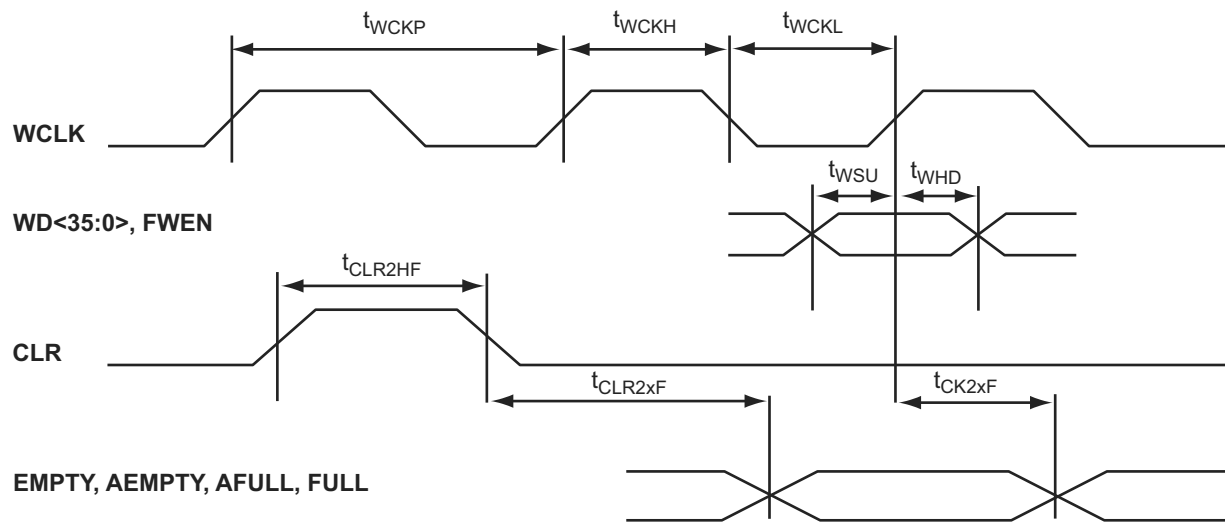


Figure 2-67 • FIFO Write Timing

mode if desired. Please note, if the I/O bank is not disabled, differential I/Os belonging to the I/O bank will still consume normal power, even when operating in the low power mode.

The Axcelerator device will resume normal operation 10 μ s after the LP pin is pulled Low.

To further reduce power consumption, the internal charge pump can be bypassed and an external power supply voltage can be used instead. This saves the internal charge-pump operating current, resulting in no DC current draw. The Axcelerator family devices have a dedicated "V_{PUMP}" pin that can be used to access an external charge pump device. In normal chip operation, when using the internal charge pump, V_{PUMP} should be tied to GND. When the voltage level on V_{PUMP} is set to 3.3V, the internal charge pump is turned off, and the V_{PUMP} voltage will be used as the charge pump voltage. Adequate voltage regulation (i.e. high drive, low output impedance, and good decoupling) should be used at V_{PUMP}.

In addition, any PLL in use can be powered down to further reduce power consumption. This can be done with the PowerDown pin driven Low. Driving this pin High restarts the PLL with the output clock(s) being stable once lock is restored.

JTAG

Axcelerator offers a JTAG interface that is compliant with the IEEE 1149.1 standard. The user can employ the JTAG interface for probing a design and performing any JTAG Public Instructions as defined in the Table 2-103.

Table 2-103 • JTAG Instruction Code

Instruction (IR4:IR0)	Binary Code
Extest	00000
Preload / Sample	00001
Intest	00010
USERCODE	00011
IDCODE	00100
HIGHZ	01110
CLAMP	01111
Diagnostic	10000
Reserved	All others
Bypass	11111

Interface

The interface consists of four inputs: Test Mode Select (TMS), Test Data In (TDI), Test Clock (TCK), TAP Controller Reset (TRST), and an output, Test Data Out (TDO). TMS, TDI, and TRST have on-chip pull-up resistors.

TRST

TRST (Test-Logic Reset) is an active-low, asynchronous reset signal to the TAP controller. The TRST input can be used to reset the Test Access Port (TAP) Controller to the TRST state. The TAP Controller can be held at this state permanently by grounding the TRST pin. To hold the JTAG TAP controller in the TRST state, it is recommended to connect TRST to ground via a 1 k Ω resistor.

There is an optional internal pull-up resistor available for the TRST input that can be set by the user at programming. Care should be exercised when using this option in combination with an external tie-off to ground.

An on-chip power-on-reset (POWRST) circuit is included. POWRST has the same function as "TRST," but it only occurs at power-up or during recovery from a VCCA and/or VCCDA voltage drop.

FG256		FG256	
AX250 Function	Pin Number	AX250 Function	Pin Number
VCCA	L9	VCCIB4	M11
VCCA	N3	VCCIB4	M9
VCCA	P14	VCCIB5	M6
VCCPLA	C7	VCCIB5	M7
VCCPLB	D6	VCCIB5	M8
VCCPLC	A10	VCCIB6	J5
VCCPLD	D10	VCCIB6	K5
VCCPLE	P10	VCCIB6	L5
VCCPLF	N11	VCCIB7	F5
VCCPLG	T7	VCCIB7	G5
VCCPLH	N7	VCCIB7	H5
VCCDA	A11	VCOMPLA	A7
VCCDA	A2	VCOMPLB	D7
VCCDA	C13	VCOMPLC	B9
VCCDA	D9	VCOMPLD	D11
VCCDA	H1	VCOMPLE	T10
VCCDA	J15	VCOMPLF	N10
VCCDA	N14	VCOMPLG	R8
VCCDA	N8	VCOMPLH	N6
VCCDA	P4	VPUMP	A14
VCCDA	R11		
VCCDA	R5		
VCCIB0	E6		
VCCIB0	E7		
VCCIB0	E8		
VCCIB1	E10		
VCCIB1	E11		
VCCIB1	E9		
VCCIB2	F12		
VCCIB2	G12		
VCCIB2	H12		
VCCIB3	J12		
VCCIB3	K12		
VCCIB3	L12		
VCCIB4	M10		

FG676	
AX500 Function	Pin Number
Bank 0	
IO00NB0F0	F8
IO00PB0F0	E8
IO01NB0F0	A5
IO01PB0F0	A4
IO02NB0F0	E7
IO02PB0F0	E6
IO03NB0F0	D6
IO03PB0F0	D5
IO04NB0F0	B5
IO04PB0F0	C5
IO05NB0F0	B6
IO05PB0F0	C6
IO06NB0F0	C7
IO06PB0F0	D7
IO07NB0F0	A7
IO07PB0F0	A6
IO08NB0F0	C8
IO08PB0F0	D8
IO09NB0F0	F10
IO09PB0F0	F9
IO10NB0F0	B8
IO10PB0F0	B7
IO11NB0F0	D10
IO11PB0F0	E10
IO12NB0F1	B9
IO12PB0F1	C9
IO13NB0F1	F11
IO13PB0F1	G11
IO14NB0F1	D11
IO14PB0F1	E11
IO15NB0F1	B10
IO15PB0F1	C10
IO16NB0F1	A10
IO16PB0F1	A9

FG676	
AX500 Function	Pin Number
IO17NB0F1	F12
IO17PB0F1	G12
IO18NB0F1	C12
IO18PB0F1	C11
IO19NB0F1/HCLKAN	A12
IO19PB0F1/HCLKAP	B12
IO20NB0F1/HCLKBN	C13
IO20PB0F1/HCLKBP	B13
Bank 1	
IO21NB1F2/HCLKCN	C15
IO21PB1F2/HCLKCP	C14
IO22NB1F2/HCLKDN	A15
IO22PB1F2/HCLKDP	B15
IO23NB1F2	F15
IO23PB1F2	G15
IO24NB1F2	B16
IO24PB1F2	A16
IO25NB1F2	A18
IO25PB1F2	A17
IO26NB1F2	D16
IO26PB1F2	E16
IO27NB1F2	F16
IO27PB1F2	G16
IO28NB1F2	C18
IO28PB1F2	C17
IO29NB1F2	B19
IO29PB1F2	B18
IO30NB1F2	D19
IO30PB1F2	C19
IO31NB1F2	F17
IO31PB1F2	E17
IO32NB1F3	B20
IO32PB1F3	A20
IO33NB1F3	B22
IO33PB1F3	B21

FG676	
AX500 Function	Pin Number
IO34NB1F3	D20
IO34PB1F3	C20
IO35NB1F3	D21
IO35PB1F3	C21
IO36NB1F3	D22
IO36PB1F3	C22
IO37NB1F3	F19
IO37PB1F3	E19
IO38NB1F3	B23
IO38PB1F3	A23
IO39NB1F3	E21
IO39PB1F3	E20
IO40NB1F3	D23
IO40PB1F3	C23
IO41NB1F3	D25
IO41PB1F3	C25
Bank 2	
IO42NB2F4	G24
IO42PB2F4	G23
IO43NB2F4	G26
IO43PB2F4	F26
IO44NB2F4	F25
IO44PB2F4	E25
IO45NB2F4	J21
IO45PB2F4	J22
IO46NB2F4	H25
IO46PB2F4	G25
IO47NB2F4	K23
IO47PB2F4	J23
IO48NB2F4	J24
IO48PB2F4	H24
IO49NB2F4	K21
IO49PB2F4	K22
IO50NB2F4	K25
IO50PB2F4	J25

FG896	
AX2000 Function	Pin Number
IO124NB2F11	P29
IO124PB2F11	P30
IO125NB2F11	R22
IO125PB2F11	R23
IO127NB2F11	R24
IO127PB2F11	R25
IO128NB2F11	R29
IO128PB2F11	R30
Bank 3	
IO129NB3F12	T27
IO129PB3F12	R27
IO130NB3F12	T29
IO130PB3F12	T30
IO131NB3F12	T22
IO131PB3F12	T23
IO132NB3F12	U26
IO132PB3F12	T26
IO133NB3F12	U24
IO133PB3F12	T24
IO135NB3F12	U23
IO135PB3F12	U22
IO136NB3F12	U29
IO136PB3F12	U30
IO137NB3F12	V28
IO137PB3F12	U28
IO138NB3F12	V27
IO138PB3F12	U27
IO139NB3F13	V25
IO139PB3F13	U25
IO141NB3F13	V23
IO141PB3F13	V22
IO142NB3F13	W29
IO142PB3F13	V29
IO143NB3F13	W26
IO143PB3F13	V26

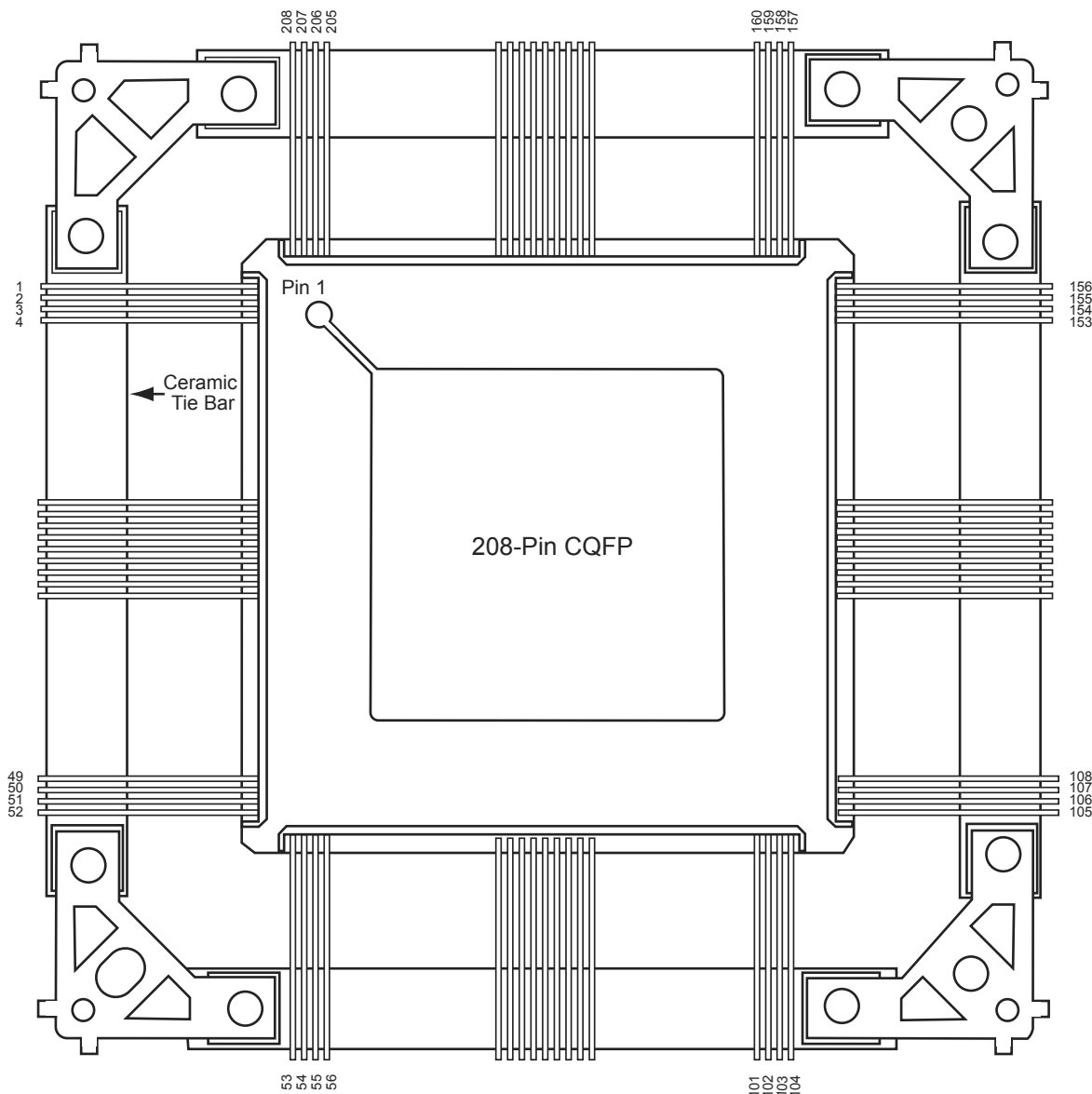
FG896	
AX2000 Function	Pin Number
IO145NB3F13	W24
IO145PB3F13	V24
IO146NB3F13	W27
IO146PB3F13	W28
IO147NB3F13	Y28
IO147PB3F13	Y27
IO148NB3F13	Y30
IO148PB3F13	W30
IO149NB3F13	Y25
IO149PB3F13	W25
IO150NB3F14	AA29
IO150PB3F14	Y29
IO151NB3F14	AC29
IO152NB3F14	AA26
IO152PB3F14	Y26
IO153NB3F14	Y23
IO153PB3F14	W23
IO154NB3F14	AB30
IO154PB3F14	AA30
IO155NB3F14	AB27
IO155PB3F14	AA27
IO156NB3F14	AC28
IO156PB3F14	AB28
IO157NB3F14	AA24
IO157PB3F14	Y24
IO158NB3F14	AF29
IO158PB3F14	AF30
IO159NB3F14	AB25
IO159PB3F14	AA25
IO160NB3F14	AE30
IO160PB3F14	AD30
IO161NB3F15	AE29
IO161PB3F15	AD29
IO162NB3F15	AD27
IO162PB3F15	AC27

FG896	
AX2000 Function	Pin Number
IO163NB3F15	AC26
IO163PB3F15	AB26
IO164NB3F15	AE28
IO164PB3F15	AD28
IO165NB3F15	AC24
IO165PB3F15	AB24
IO166NB3F15	AG28
IO166PB3F15	AF28
IO167NB3F15	AE26
IO167PB3F15	AD26
IO168NB3F15	AD25
IO168PB3F15	AC25
IO169NB3F15	AF27
IO169PB3F15	AE27
IO170NB3F15	AB23
IO170PB3F15	AA23
Bank 4	
IO171NB4F16	AG29
IO171PB4F16	AG30
IO172NB4F16	AF24
IO172PB4F16	AF25
IO173NB4F16	AG25
IO173PB4F16	AG26
IO174NB4F16	AJ25
IO174PB4F16	AJ26
IO175NB4F16	AK26
IO175PB4F16	AK27
IO176NB4F16	AE23
IO176PB4F16	AE24
IO177NB4F16	AH24
IO177PB4F16	AH25
IO178NB4F16	AD23
IO178PB4F16	AC23
IO179PB4F16	AJ27
IO180NB4F16	AG23

FG1152		FG1152		FG1152	
AX2000 Function	Pin Number	AX2000 Function	Pin Number	AX2000 Function	Pin Number
GND	AK12	GND	AN34	GND	D1
GND	AK17	GND	AN4	GND	D11
GND	AK18	GND	AN9	GND	D2
GND	AK23	GND	AP13	GND	D24
GND	AK30	GND	AP2	GND	D3
GND	AK5	GND	AP22	GND	D31
GND	AL1	GND	AP27	GND	D32
GND	AL11	GND	AP3	GND	D33
GND	AL2	GND	AP31	GND	D34
GND	AL24	GND	AP32	GND	D4
GND	AL3	GND	AP33	GND	E12
GND	AL31	GND	AP4	GND	E17
GND	AL32	GND	AP8	GND	E18
GND	AL33	GND	B1	GND	E23
GND	AL34	GND	B2	GND	E30
GND	AL4	GND	B26	GND	E5
GND	AM1	GND	B3	GND	F29
GND	AM10	GND	B31	GND	F30
GND	AM15	GND	B32	GND	F6
GND	AM2	GND	B33	GND	G28
GND	AM20	GND	B34	GND	G7
GND	AM25	GND	B4	GND	H1
GND	AM3	GND	B9	GND	H34
GND	AM31	GND	C1	GND	J2
GND	AM32	GND	C10	GND	J33
GND	AM33	GND	C15	GND	K3
GND	AM34	GND	C2	GND	K32
GND	AM4	GND	C20	GND	L11
GND	AN1	GND	C25	GND	L24
GND	AN2	GND	C3	GND	L31
GND	AN26	GND	C31	GND	L4
GND	AN3	GND	C32	GND	M12
GND	AN31	GND	C33	GND	M23
GND	AN32	GND	C34	GND	M30
GND	AN33	GND	C4	GND	M5

FG1152		FG1152		FG1152	
AX2000 Function	Pin Number	AX2000 Function	Pin Number	AX2000 Function	Pin Number
GND	N1	GND	U19	NC	A26
GND	N13	GND	U20	NC	AB2
GND	N22	GND	U21	NC	AB33
GND	N34	GND	U30	NC	AC34
GND	P14	GND	U5	NC	AD3
GND	P15	GND	V14	NC	AD34
GND	P16	GND	V15	NC	AE31
GND	P17	GND	V16	NC	AE33
GND	P18	GND	V17	NC	AE34
GND	P19	GND	V18	NC	AF1
GND	P20	GND	V19	NC	AF34
GND	P21	GND	V20	NC	AG2
GND	R14	GND	V21	NC	AG4
GND	R15	GND	V30	NC	AH1
GND	R16	GND	V5	NC	AH2
GND	R17	GND	W14	NC	AH31
GND	R18	GND	W15	NC	AH32
GND	R19	GND	W16	NC	AH34
GND	R20	GND	W17	NC	AJ1
GND	R21	GND	W18	NC	AJ2
GND	R3	GND	W19	NC	AJ3
GND	R32	GND	W20	NC	AJ31
GND	T14	GND	W21	NC	AJ32
GND	T15	GND	Y14	NC	AJ33
GND	T16	GND	Y15	NC	AJ34
GND	T17	GND	Y16	NC	AJ4
GND	T18	GND	Y17	NC	AL29
GND	T19	GND	Y18	NC	AM19
GND	T20	GND	Y19	NC	AM7
GND	T21	GND	Y20	NC	AN13
GND	U14	GND	Y21	NC	AN17
GND	U15	GND	Y3	NC	AN25
GND	U16	GND	Y32	NC	AN27
GND	U17	GND/LP	G6	NC	AN8
GND	U18	NC	A17	NC	AP17

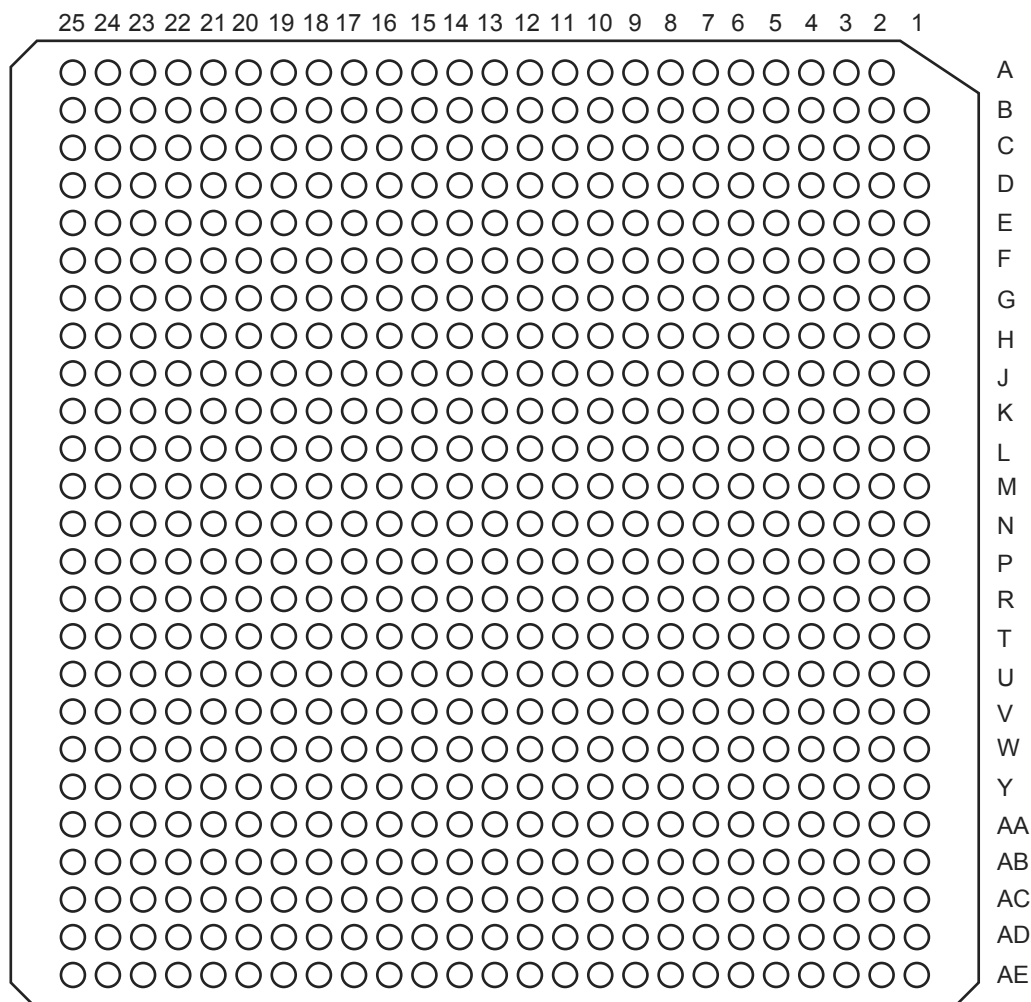
CQ208



Note

For Package Manufacturing and Environmental information, visit Resource center at <http://www.microsemi.com/soc/products/rescenter/package/index.html>.

CG624



Note

For Package Manufacturing and Environmental information, visit Resource center at <http://www.microsemi.com/soc/products/rescenter/package/index.html>.